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Substitute Form PTO-1449 (Modified)

U.S. Department of Commerce Patent and Trademark Office Attorney's Docket No. 12732-033001

Application No.
Not yet assigned

Information Disclosure Statement Sh Sh

Applicant

Shunpei YAMAZAKI et al.

Filing Date April 25, 2001

Group Art Unit Unknown 09/841156 04/25/01

(37 CFR §1.98(b))

	U.S. Patent Documents						
Examiner Initial	Desig. ID	Patent Number	Issue Date	Patentee	Class	Subclass	Filing Date If Appropriate
EK	AA	5,643,826	07/1/1997	Ohtani et al.			1.1
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	AI							
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	Other Documents (include Author, Title, Date, and Place of Publication)							
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EK_	AL	M. A. Baldo et al., "Highly Efficient Phosphorescent Emission from Organic Electroluminescent Devices", Nature Vol. 395, September 10, 1998, pp. 151-154.						
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EK	AO	Japanese Patent Application Laid-Open No. 7-130652 (English Abstract attached) Publication Date 05/19/1995						
EK	AP	Japanese Patent Application Laid-Open No. 8-96959 (English Abstract attached) Publication Date 04/12/1996						
EK	AQ	Japanese Patent Application Laid-Open No. 9-63770 (English Abstract attached) Publication Date 03/07/1997						
EK-	AR	U.S. Patent Application No. 09/724,387						
EK_	AS	U.S. Patent Application No. 09/760,499						

Examiner Signature	Date Considered /D/Z/DZ
EXAMINER: Initials citation considered. Draw line through citation if no	t in conformance and not considered. Include copy of this form with
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Part # 8 Sheet <u>1</u> of <u>1</u>

Substitute Form PTO-1449 (Modified)

U.S. Department of Commerce Patent and Trademan

Attorney's Docket No. 12732-033001

Application No. 09/841,156

Information Disclosure Statement by Applicant (Use several sheets if necessary) Applicant Shunpei Yamazaki et al.

Group Art Unit

(37 CFR §1.98(b))

Filing Date April 25, 2001

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-	U.S. Patent Documents						
Examiner Initial	Desig. ID	Patent Number	Issue Date	Patentee	Class	Subclass	Filing Date If Appropriate
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	Other Documents (include Author, Title, Date, and Place of Publication)							
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Substitute Disclosure Form (PTO-1449)

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Sheet <u>1</u> of <u>1</u>

Substitute Form PTO-143 (Modified)

U.S. Department of Commerce Patent and Trademark Office

Attorney's Docket No. 12732-033001

Application No. 09/841,156

Information Disclosure Statement by Applicant

(Use several sheets if necessary)

Applicant

Shunpei YAMAZAKI et al.

Filing Date -

Group Art Unit -

(37 CFR §1.98(b))

April 25, 2001

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	U.S. Patent Documents						
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	Other Documents (include Author, Title, Date, and Place of Publication)							
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Substitute Disclosure Form (PTO-1449)



Part of #11 Sheet <u>1</u> of <u>1</u>

Substitute Form PTO-1449 (Modified)

U.S. Department of Commerce Patent and Trademark Office

Attorney's Docket No. 12732-033001

Application No. 09/841,156

**by Applicant** (Use several sheets if necessary)

Shunpei YAMAZAKI et al.

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(37 CFR §1.98(b))

Filing Date April 25, 2001

Applicant

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Foreign Patent Documents or Published Foreign Patent Applications								
Examiner Initial	Desig. ID	Document Number	Publication Date	Country or Patent Office	Class	Subclass		lation No
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Other Documents (include Author, Title, Date, and Place of Publication)				
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Examiner Signature	Date Considered  /D/z_/07_
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